

<b>Notice of References Cited</b>	Application/Control No. 10/066,631	Applicant(s)/Patent Under Reexamination ANTTILA ET AL.	
	Examiner KIEU-OANH T. BUI	Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,778,834 B2	08-2004	Laitinen et al.	455/450
	B	US-2004/0237109 A1	11-2004	Laitinen et al.	725/062
	C	US-2002/0056123 A1	05-2002	Liwerant et al.	725/87
	D	US-2003/0110503 A1	06-2003	Perkes, Ronald M.	725/86
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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